

**Search Notes**

Application/Control No.

10/750,024

Examiner

James A. Dudek

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
updated		3/14/2006	JAD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR